

Issue Classification			Application/Control No.	Applicant(s)/Patent under Reexamination	
			10/661,674	OSAWA ET AL.	
			Examiner	Art Unit	
			BINH Q. TRAN	3748	

ORIGINAL			CROSS REFERENCE(S)							
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
60	285	60	274	277	284					
INTERNATIONAL CLASSIFICATION			180	65.2	65.3	65.4				
F	O	I	N	3	100					
				/						
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			 Binh Q. Tran 11/11/05 Patent Examiner Technology Center 3700 <small>(Primary Examiner) (Date)</small>							
(Assistant Examiner) (Date)									Total Claims Allowed: 7	
(Legal Instruments Examiner) (Date)									O.G. Print Claim(s) 1	O.G. Print Fig. 5

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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5	5	35	65	95	125	155	185
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8	8	38	68	98	128	158	188
9	9	39	69	99	129	159	189
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11	11	41	71	101	131	161	191
12	12	42	72	102	132	162	192
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15	15	45	75	105	135	165	195
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